

<b>Search Notes</b>  	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10779744	DOI ET AL.
<b>Examiner</b>	<b>Art Unit</b>	
LIN LIU	2445	

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
709	201-203, 217-219	08/28/2008	L.L
715	209-210	08/28/2008	L.L

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Text search of USPAT, USPGPUB, EPO, JPO, DERWENT, IBM_TDB, see search history printout.	08/28/2008	L.L
Text searched with ( 709/201-203, 217-219) and (715/209-210)	08/28/2008	L.L
Dialog search attached	08/28/2008	L.L
Google Patent search attached.	08/28/2008	L.L
Updated Text search of USPAT, USPGPUB, EPO, JPO, DERWENT, IBM_TDB, see search history printout.	03/22/2009	L.L
Updated Google patent search attached.	03/22/2009	L.L
Updated Text search of USPAT, USPGPUB, EPO, JPO, DERWENT, IBM_TDB, see search history printout.	9/24/2009	L.L
Updated Google patent search attached.	9/24/2009	L.L
Updated Text search of USPAT, USPGPUB, EPO, JPO, DERWENT, IBM_TDB, see search history printout.	3/23/2010	L.L
Updated Google patent search attached.	3/23/2010	L.L
Dialog search attached.	3/23/2010	L.L
Consulted with Srivastava, Vivek for the allowable subject matter.	3/16/2010	L.L

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
	See BRS search attached.	3/23/2010	L.L